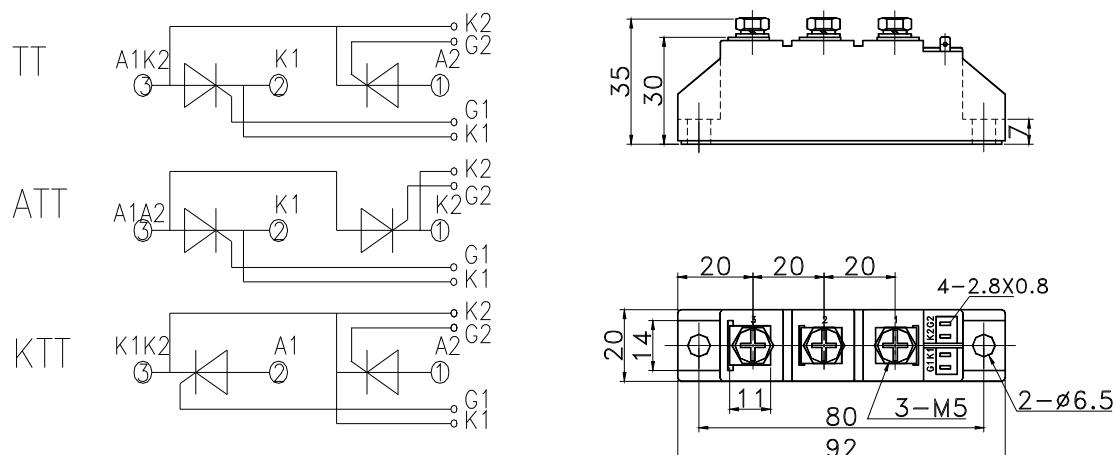


TT70 ATT70 KTT70

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	T_j (°C)	VALUE			UNIT
				Min	Type	Max	
$I_{T(AV)}$	Mean on-state current	180° half sine wave 50Hz Single side cooled, $T_c=85^\circ C$	125			70	A
$I_{T(RMS)}$	RMS on-state current	Single side cooled, $T_c=85^\circ C$	125			110	A
V_{DRM} V_{RRM}	Repetitive peak off-state voltage Repetitive peak reverse voltage	$V_{DRM} \& V_{RRM}$ tp=10ms $V_{DsM} \& V_{RsM} = V_{DRM} \& V_{RRM} + 200V$ respectively	125	600		1800	V
I_{DRM} I_{RRM}	Repetitive peak current	at V_{DRM} at V_{RRM}	125			10	mA
I_{TSM}	Surge on-state current	10ms half sine wave	125			1.60	KA
I^2t	I^2T for fusing coordination	$V_R=60\%V_{RRM}$				13.0 $A^2s * 10^3$	
V_{TO}	Threshold voltage		125			0.80	V
r_T	On-state slop resistance					2.64	$m\Omega$
V_{TM}	Peak on-state voltage	$I_{TM}=210A$	125			1.48	V
dv/dt	Critical rate of rise of off-state voltage	$V_{DM}=67\%V_{DRM}$	125			800	V/ μ s
di/dt	Critical rate of rise of on-state current	From 67% V_{DRM} to 210A, Gate source 1.5A $t_r \leq 0.5\mu s$ Repetitive	125			50	A/ μ s
I_{GT}	Gate trigger current		25	30		100	mA
V_{GT}	Gate trigger voltage	$V_A=12V, I_A=1A$		0.8		2.0	V
I_H	Holding current			20		100	mA
V_{GD}	Non-trigger gate voltage	At 67% V_{DRM}	125			0.2	V
$R_{th(j-c)}$	Thermal resistance Junction to heatsink	At 180° sine Single side cooled				0.410	$^\circ C / W$
V_{iso}	Isolation voltage	50Hz, R.M.S, t=1min, I_{iso} :1mA(MAX)		2500			V
F_m	Thermal connection torque(M5)				0.20		N·m
	Mounting torque(M6)				0.30		N·m
T_{stg}	Stored temperature			-40		140	$^\circ C$
W_t	Weight				100		g
Outline		201F3					

OUTLINE DRAWING & CIRCUIT DIAGRAM



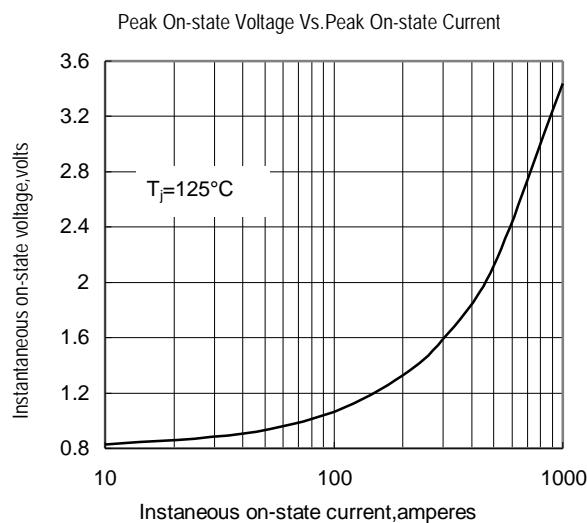


Fig.1

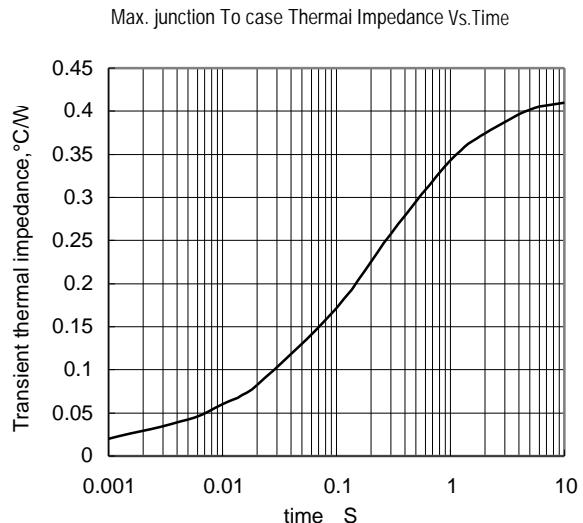


Fig.2

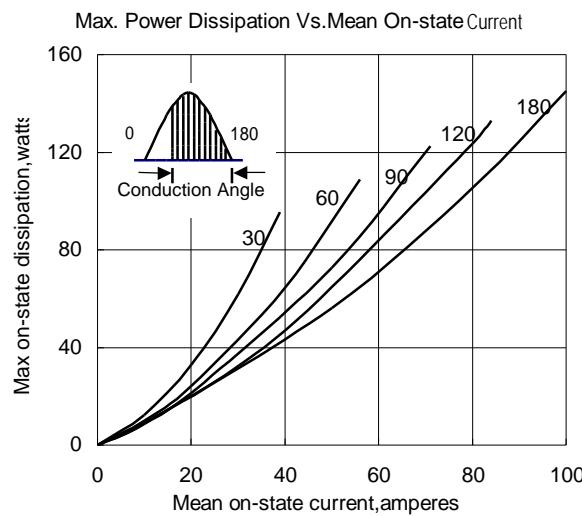


Fig.3

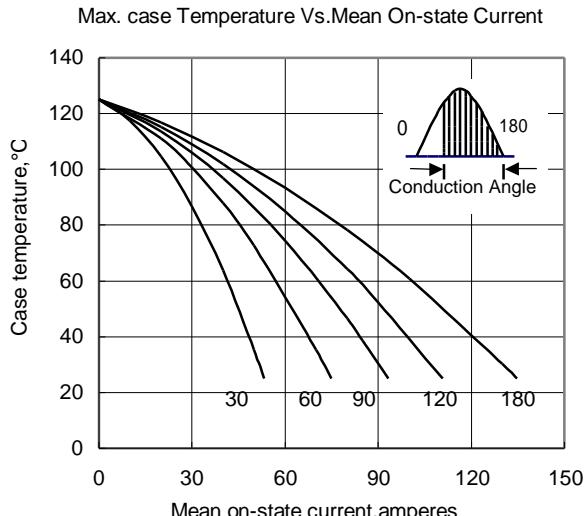


Fig.4

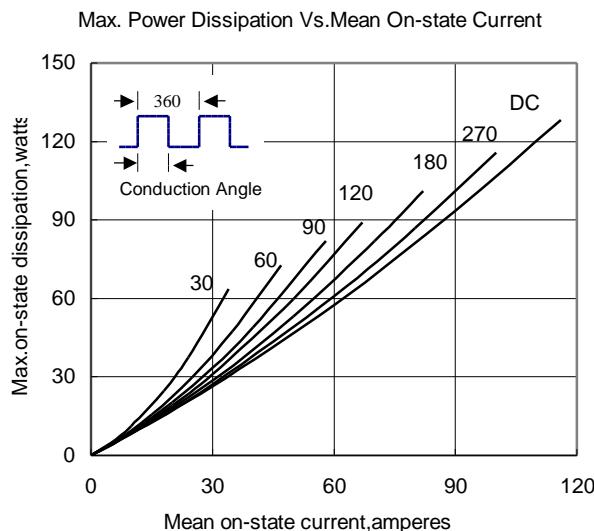


Fig.5

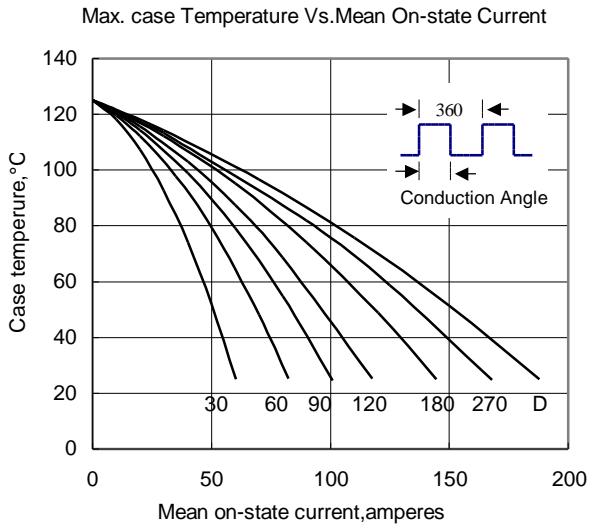


Fig.6

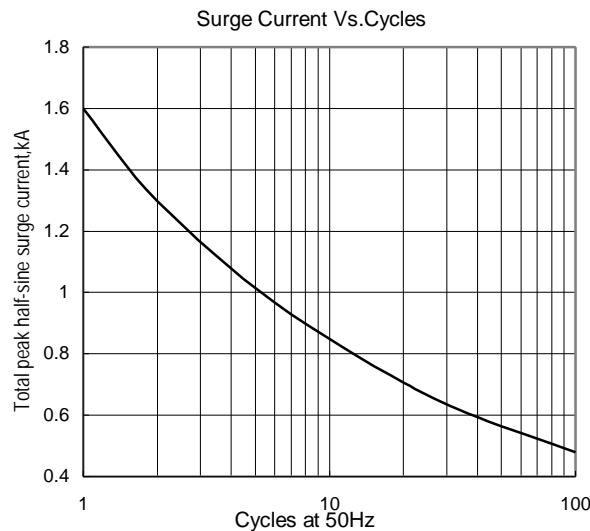


Fig.7

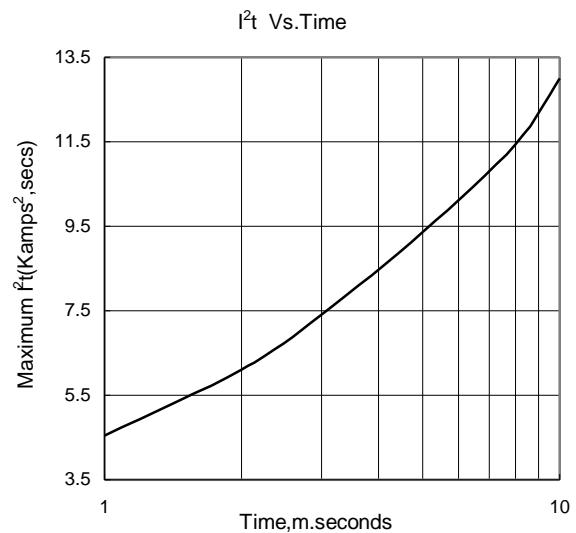


Fig.8

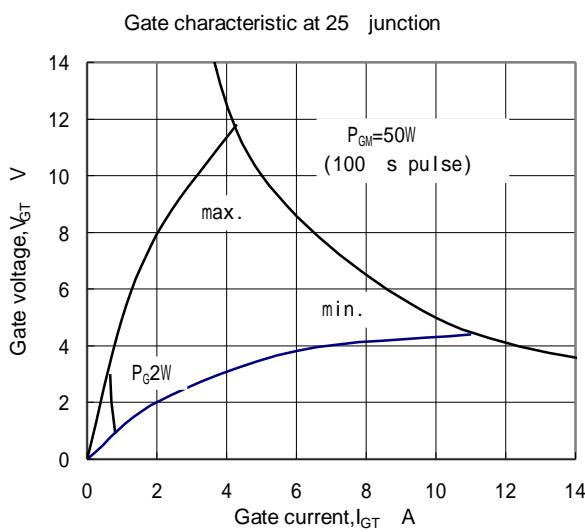


Fig.9

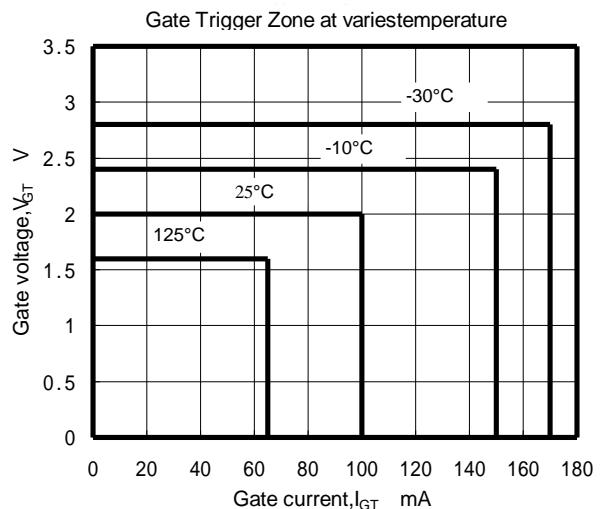


Fig.10